# Tapered Cavities for High-Modulation-Efficiency and Low-Distortion Semiconductor Lasers

Farhan Rana, Christina Manolatou, and Martin F. Schubert

Abstract—We show that mode structure and cavity geometry in multisegment semiconductor lasers can be tailored to realize high modulation efficiencies as well as low distortion levels in directly modulated semiconductor lasers using the gain-lever effect. Compared with conventional semiconductor gain-lever lasers, the lasers proposed here can have five times higher modulation efficiencies. The second-order harmonic and third-order two-tone intermodulation distortion levels in the proposed lasers are also significantly lower than in conventional gain-lever lasers. We also show that, in the lasers proposed here, unlike in conventional gain-lever lasers, modulation bandwidths and output power levels may not be sacrificed in order to obtain high modulation efficiencies.

*Index Terms*—Harmonic distortion, intermodulation distortion, laser modulation, semiconductor lasers.

#### I. INTRODUCTION

IRECTLY modulated semiconductor lasers are attractive low-cost sources for analog fiber-optic links for applications, such as cable television (CATV) distribution systems, micro-cellular and pico-cellular fiber/coax hybrid links, and phased-arrayed antenna systems [1]-[3]. In conventional semiconductor lasers, each electron (or hole) injected into the device emits at best a single photon and the differential slope efficiency (watts/amps) is limited by  $\hbar\omega/e$ . The gain of an analog fiber-optic link is proportional to the square of the laser differential slope efficiency and, therefore, a high laser differential-slope efficiency is desirable [1]. Various laser designs have been demonstrated that beat the  $\hbar\omega/e$  limit. The slope efficiency of bipolar cascade lasers increases in proportion to the number of cascaded gain sections and can therefore be much in excess of the conventional limit  $\hbar\omega/e$ . Bipolar cascade lasers with two to three cascaded gain stages have been demonstrated [4]–[7]. The gain in slope efficiency in bipolar cascade lasers comes at the expense of increased device complexity, increased device heating, and increased nonlinearities from the reversed biased Esaki junctions that connect the cascaded gain stages.

Semiconductor gain-lever lasers have also demonstrated large differential slope efficiencies [8], [9]. In a two-segment semiconductor gain-lever laser, the longer segment is heavily forward biased, and only the shorter segment is used for direct current modulation. An increase in the current in the shorter

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segment increases the carrier density in that segment, causing a large increase in the photon density inside the cavity. The carrier density in the longer segment must decrease so that, in steady state, the round-trip cavity gain equals the cavity loss. The decrease in the carrier density in the longer section comes about as a result of the increased stimulated emission rate due to the increased photon density in the cavity. The large increase in the photon population in the laser cavity results in a large value for the laser differential slope efficiency. Although gain-lever lasers have demonstrated differential slope efficiencies three to five times larger than those of conventional lasers [9], the nonlinearity of the light-versus-current (L-I curve) characteristics of gain-lever lasers results in large signal distortions. In particular, the second-order harmonic distortion (HMD2) and the two-tone third-order intermodulation distortion (IMD3) of gainlever lasers have been found to be too large for practical applications [10]. In addition, at bias points where the differential slope efficiency is large, the nonlinearities are also large, and the laser output power and the laser modulation bandwidth are both small [10]. An exception to this is the recent results in which optical injection locking was used to increase the modulation bandwidth and reduce the nonlinearities in a gain-lever distributed feedback reflector (DBR) laser at the expense of increased device and system complexity [11]. In particular, a reduction in HMD2 of ~16 dB and a reduction in IMD3 of ~15 dB was reported in [11] without sacrificing the laser modulation bandwidth.

In this paper, we show that the cavity structure in gain-lever semiconductor lasers can be modified to enhance the differential slope efficiency even at large output power levels. We show that this can be achieved together with an increase in the modulation bandwidth and a reduction in the distortion levels. The improvement in the differential slope efficiency compared with conventional gain-lever lasers is related to the device geometry and dimensions and is therefore less sensitive to the dc biasing of the laser. We present cavity designs that have up to three times larger modulation bandwidths, a reduction in HMD2 approaching 20 dB, and a reduction in IMD3 approaching 40 dB, compared with conventional gain-lever lasers for the same modulation efficiency. The laser structures discussed in this paper can lead to cost-effective, high-modulation-efficiency, and low-distortion sources for analog fiber-optic links.

# II. CAVITY GEOMOTRIES FOR HIGH-MODULATION-EFFICIENCY LASERS

In order to illustrate the essential ideas, we consider the twosegment laser cavity shown in Fig. 1.  $L_1$  and  $L_2$  are the lengths

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Fig. 1. Top: A two-segment semiconductor laser with different transverse-mode areas in the two segments. Bottom: A 3D-FDTD simulation of a hyperbolic-tangent mode converter connecting fundamental modes of 1- and  $5-\mu$ m-wide waveguides. More than 96% of the power is transmitted from the fundamental mode in the narrow segment to the fundamental mode in the wide segment and vice versa. Approximately 2% of the incident power is lost to radiation. The power reflected is less than  $10^{-3}$  (both ways).

of the two segments of the laser,  $A_1$  and  $A_2$  are the cross-sectional areas of the active region in the two segments, and  $\Gamma_1$  and  $\Gamma_2$  are the transverse-mode gain-confinement factors in the two segments [12]. The transverse-mode effective areas  $A_{p1}$  and  $A_{p2}$  in the two segments are  $A_1/\Gamma_1$  and  $A_2/\Gamma_2$ , respectively. Ignoring the tapered section (assuming  $2L_T \ll L_1, L_2$ ), the rate equations for the carrier densities  $N_1$  and  $N_2$  in the two segments, and the average photon density  $N_p$  in the laser cavity can be written as

$$\frac{dN_m}{dt} = \eta_i \frac{I_m}{eV_m} - R(N_m) - h_m v_g g_m N_p, \qquad m = 1,2 \quad (1)$$
$$\frac{dN_p}{dt} = \left(\sum_{m=1,2} \Gamma_m \frac{L_m}{L} v_g g_m\right) N_p - \frac{N_p}{\tau_p}. \quad (2)$$

Here, L equals  $L_1 + L_2$ , the mode effective volume  $V_p$  equals  $A_{p1}L_1 + A_{p2}L_2$ , and the active region volumes  $V_1$  and  $V_2$  of the two segments equal  $A_1L_1$  and  $A_2L_2$ , respectively.  $R(N_m)$  are the carrier-density-dependent recombination rates. The factors  $h_m$  relate the average photon density  $N_p$  to the actual photon density in each segment and are given by  $h_m = V_p/A_{pm}L$ . It is assumed that the narrow segment supports only a single transverse mode which transforms between the narrow and the wide segments of the laser without generating reflections and without exciting higher order transverse modes in the wide segment. The above equations give the following result for the laser differential-slope efficiency:

$$\frac{dP_{\text{out}}}{dI_1} = \left(\eta_o \eta_i \frac{\hbar\omega}{e}\right) \frac{\Gamma_1 g_1 L_1 + \Gamma_2 g_2 L_2}{\Gamma_1 g_1 L_1 + X \Gamma_2 g_2 L_2} \tag{3}$$

where X is given as

Here,  $\eta_o$  is the output coupling efficiency, and  $\tau_1$  and  $\tau_2$  are the carrier differential recombination lifetimes in the two segments [12]. Note that the first factor in brackets on the right-hand side in (3) is the differential slope efficiency of a conventional laser [12]. The term outside the brackets describes the enhancement due to the gain-lever effect. If  $\Gamma_2 g_2 L_2 \gg \Gamma_1 g_1 L_1$  and X < 1, the enhancement in the slope efficiency is given by  $\sim 1/X$ . Compared with a conventional gain-lever laser, the value of Xfor a laser with different transverse-mode areas in the two segments is reduced by the ratio  $A_{p1}/A_{p2}$ . As we show below, the mode areas in the two segments can be made different by factors as large as ten, and therefore the enhancement in the differential-slope efficiency compared to conventional gain-lever lasers can be significant. This enhancement can be traded off for reduced nonlinearity, increased modulation bandwidth, and increased output power.

#### **III. NUMERICAL SIMULATION RESULTS**

For a more detailed analysis, we present numerical simulation results for two-segment lasers having different widths  $W_1$ and  $W_2$  in the two segments (as shown in Fig. 1). We consider a three-quantum-well (70 Å each) InGaAsP–InP active region (1.55- $\mu$ m wavelength;  $L_1 = 100 \ \mu$ m and  $L_2 = 200 \ \mu$ m). The ratio  $A_{p2}/A_{p1}$  of the transverse-mode areas in the two segments approximately equals the ratio  $W_2/W_1$  of the widths of the two segments. A variety of adiabatic as well as nonadiabatic compact mode-converter designs have been reported in the literature [13]. We consider one of the simpler designs and assume that the two segments are joined by a hyperbolic-tangent adiabatic mode converter in which the waveguide width W(z) is given approximately by

$$W(z) = \frac{W_2 + W_1}{2} + \frac{W_2 - W_1}{2} \tanh\left(\frac{z - z_o}{L_T}\right).$$
 (5)

The location  $z_o$  is at the center of the mode converter. More than 75% of the of the width transition occurs in a length  $2L_T$ . In simulations, the width  $W_1$  of the narrow segment is assumed to be 1  $\mu$ m and the width  $W_2$  of the wide segment is varied. Losses associated with mode conversion are calculated using three-dimensional finite-difference time-domain (3D-FDTD). Fig. 1 shows the transverse mode for  $W_2 = 5 \ \mu m$  and  $L_T = 10 \ \mu m$ . More than 96% of the power is transmitted from the fundamental mode in the narrow segment to the fundamental mode in the wide segment and vice versa. Approximately 2% of the incident power is lost to radiation. The power reflected is less than  $10^{-3}$  (both ways). For  $W_2 = 10 \ \mu \text{m}$  and  $L_T = 25 \ \mu \text{m}$ , the power transmitted is more than 89% (both ways), and the power reflected is less than  $10^{-3}$  (both ways). We should emphasize here that the performance parameters of the lasers proposed here, such as modulation efficiency and distortion, are not a sensitive function of the mode-converter design or characteristics as long as the mode converter is relatively compact (i.e., the length of the mode converter is small compared with the total length of the laser), does not introduce excessive losses, and does not generate large reflections. Excessive losses could result in increased threshold current density, increased device

Parameter	Value
Length $L_1,L_2$ , and $L_T$	100, 200, and 25 $\mu$ m, respectively
Gain confinement factors $\Gamma_1$ and $\Gamma_2$	.04 and .04, respectively
Width $W_1$	1 $\mu$ m
Current injection efficiency $\eta_i$	0.85
Recombination rate model	$R(N) = AN + BN^2 + CN^3$
Recombination parameter $A$	$5 imes 10^7$ l/s
Recombination parameter $B$	$10^{-10} \text{ cm}^3/\text{s}$
Recombination parameter ${\boldsymbol C}$	$5 imes 10^{-29}$ cm $^6/{ m s}$
Gain model	$g = (g_o/(1+\epsilon N_p)) \ln(N/N_{tr})$
Parameter $g_o$	1800 1/cm
Transparency density $N_{tr}$	$1.7\times10^{18}~\rm 1/cm^3$
Gain compression factor $\epsilon$	$5\times 10^{-17}~{\rm cm}^3$
Waveguide intrinsic loss $lpha_i$	10 1/cm
Product of facet reflectivities	0.9×0.1

 TABLE I

 LASER PARAMETER VALUES USED IN SIMULATIONS [12]

heating, and reduced modulation efficiency. A longer mode converter would result in a shorter length for the wider segment for the same total laser length, resulting in reduced modulation efficiency (total laser length can be increased but only at the expense of the modulation bandwidth). Our choice for hyperbolic-tangent adiabatic mode converter is dictated more by simplicity than performance. For example, adiabatic parabolic and more sophisticated nonadiabatic mode converters have been reported to achieve more than 95% transmission over only a few micrometers distances between waveguides with width ratios larger than 5 [13]. However, the performance provided by the hyperbolic-tangent mode converter is more than adequate to demonstrate the characteristics of the proposed lasers. The assumed values of the other device parameters are shown in Table I. The device is HR/AR-coated for most of the light to come out of the facet on the side of the narrow segment for better output mode quality. The length  $L_T$  for the taper is assumed to be 25  $\mu$ m. The length of the entire laser structure is  $L_1 + L_2 + 2L_T$ . Our simulations include the effects of longitudinal as well as transverse spatial hole burning in the rate equations, as in [14]. For every bias point, the photon density is found at every location in the laser cavity (assuming only a single transverse lasing mode), and its value is used to set up time-dependent rate equations for the carrier density at every location in the laser cavity and the average photon density in the laser cavity [14]. These rate equations are used to compute the direct current modulation response of the laser. The carrier-photon dynamics in the tapered section are therefore also included in the analysis. Carrier diffusion effects have been ignored for simplicity.

Fig. 2 shows the calculated output powers and slope efficiencies (normalized to the slope efficiency  $\eta_0 \eta_i \hbar \omega/e = 0.41$  mW/mA of a conventional single-segment laser of equal length) as a function of the current  $I_1$  in the narrow segment for different values of the width  $W_2$  of the wide segment. The bias current  $I_2$  in the wide segment has values equal to 11, 27.5, 55, and 110 mA for lasers with width  $W_2$  equal to 1, 2.5,



Fig. 2. Slope efficiencies (solid line) and output powers (dashed line) are plotted as a function of the current  $I_1$  in the narrow segment for different widths  $W_2$  of the wide segment. The bias currents  $I_2$  in the wide segment for widths 1.0, 2.5, 5.0, and 10  $\mu$ m are 11, 27.5, 55, and 110 mA, respectively. The slope efficiencies are normalized to the slope efficiency  $\eta_o \eta_i \hbar \omega/e$  of a conventional single-segment laser of equal length. Values of the device parameters are shown in Table I.

5, and 10  $\mu$ m, respectively. The current  $I_2$  is chosen such that, when  $I_1 = 0$ , the gain  $g_2$  provided by the wide segment is as large as possible without causing lasing [8]–[11]. Fig. 2 shows that the slope efficiency of the laser increases with the ratio  $W_2/W_1$ . In a conventional gain-lever laser,  $W_2 = W_1$ , and the slope efficiency enhancement occurs only for small values of the current  $I_1$  and the output power. When the ratio  $W_2/W_1$  is large, the slope efficiency is large even for large values of the current  $I_1$  and the output power. In a conventional gain-lever laser, at small bias current values for which the slope efficiency is large, the rate of change of the slope efficiency with the bias current is also large. Thus, slope efficiency enhancement comes at the expense of increased nonlinearity and reduced dynamic range for RF modulation. However, when  $W_2/W_1$  is large, the laser can be biased well above threshold where the slope



Fig. 3. HMD2 normalized to the fundamental is plotted as a function of the frequency of the fundamental for different values of the width  $W_2$  of the wide segment. The bias currents  $I_2$  in the wide segment for widths 1.0, 2.5, 5.0, and 10  $\mu$ m are 11, 27.5, 55, and 110 mA, respectively. The bias currents  $I_1$  are such that the differential slope efficiency of each laser structure is three times that of a conventional single-segment laser of equal total length. Values of the device parameters are shown in Table I.

efficiency is still relatively large but the nonlinearity is small and the dynamic range is large. The enhancement of the slope efficiency with the ratio  $W_2/W_1$  can be explained as follows. When the current  $I_1$  in the narrow segment increases, the carrier density in that segment also increases. Since the round-trip gain is fixed above threshold and equals the round-trip cavity loss, the gain, and therefore the carrier density, in the wide segment must decrease. This decrease comes about as a result of an increase in the photon generation rate through stimulated emission. If the width  $W_2$  is large, then the rate generation of photons will also be large so as to achieve the desired reduction in the carrier density.

### IV. MODULATION DISTORTION PRODUCTS (HMD2 AND IMD3)

Here, we show that high modulation efficiencies obtained through tapered cavity designs can be sacrificed a little to achieve increased modulation bandwidths and reduced distortions. In order to compare the high-frequency performance and distortion levels in laser structures with different widths  $W_2$  of the wide segment, we assume that each laser structure is biased such that its differential slope efficiency is three times that of a conventional single-segment laser. Under this assumption, the 3-dB modulation bandwidths are approximately 3.3, 5, 7, and 9.5 GHz for lasers with  $W_2$  values equal to 1, 2.5, 5, and 10  $\mu$ m, respectively. Therefore, larger values of the ratio  $W_2/W_1$  enable larger modulation bandwidths for the same slope efficiency enhancement. HMD2 and two-tone IMD3 are calculated from the rate equations using the standard methods [1], [14]. For IMD3 calculations, we assume an RF input consisting of two frequencies  $f_1$  and  $f_2$  centered at the carrier frequency and separated by 1 MHz. The intermodulation distortion product at  $2f_2 - f_1$  is evaluated. The RF power for each input frequency is assumed to be -20 dBm. Fig. 3 shows HMD2 (normalized to the fundamental) as a function of frequency for different values of the width  $W_2$  of the wide segment. It can be seen that HMD2 is reduced by about 20 dB at 1 GHz when the ratio  $W_2/W_1$  is



Fig. 4. The two-tone IMD3 normalized to the fundamental is plotted as a function of the frequency of the carrier for different values of the width  $W_2$  of the wide segment. The frequencies  $f_1$  and  $f_2$  of the input signals are assumed to be centered around the carrier frequency and separated by 1 MHz. The distortion product at  $2f_2 - f_1$  is calculated for IMD3. The bias currents  $I_2$  in the wide segment for widths 1.0, 2.5, 5.0, and 10  $\mu$ m are 11, 27.5, 55, and 110 mA, respectively. The bias currents  $I_1$  are such that the differential slope efficiency of each laser structure is 3 times that of a conventional single-segment laser of equal total length. Values of the device parameters are shown in Table I.

increased from 1 to 10. Fig. 4 shows IMD3 (normalized to the fundamental) as a function of frequency for different values of the width  $W_2$  of the wide segment. Fig. 4 shows that IMD3 is also reduced by approximately 35 dB at 1 GHz when the ratio  $W_2/W_1$  is increased from 1 to 10. The distortion products are seen to have constant frequency-independent values at small frequencies. This is due to the intrinsic nonlinearity of the gain-lever effect which dominates over nonlinearities due to spatial hole burning. In simulations, the value of the gain compression factor  $\epsilon$  was assumed to be  $5 \times 10^{-17}$  cm<sup>3</sup> [12], [14]. However, gain compression was found to have negligible effect on the HMD2 and IMD3 values shown in Figs. 3 and 4.

It needs to be pointed out here that the value of the parameter X in (3) increases with the bias current  $I_1$  and can even become greater than unity. When this happens, the slope efficiency of the laser becomes less than that of a conventional single-segment laser. This can be seen to happen for the case  $W_2/W_1 = 1$  in Fig. 2 for  $I_1 > 5.5$  mA. However, the values of  $I_1$  for which X becomes unity increase with the value of the ratio  $W_2/W_1$ . Consequently, larger values of the ratio  $W_2/W_1$ allow a wider range of bias values over which the slope efficiency is enhanced. It should be noted here that the specific example of the tapered two-segment laser structure considered here is not the only design by which the transverse-mode areas in the two segments of the laser can be made different. For example, vertical mode converters, reported in [15], can be used to change the mode-confinement factors in the two segments while keeping the same active area, and the ratio  $A_{p1}/A_{p2}$  of the transverse-mode areas would then equal the ratio  $\Gamma_2/\Gamma_1$  of the mode-confinement factors.

Finally, it needs to be mentioned here that, at very large values of  $I_1$  and output power, device heating, multitransverse-mode lasing, and other nonidealities could become important, and the analysis presented in this paper may not be adequate. Similarly, the maximum achievable values of the ratio  $W_2/W_1$  could be limited by factors, such as device heating and multitransversemode lasing, that have not been considered in this paper.

## V. CONCLUSION

We have presented a method to increase the differential slope efficiency of semiconductor gain-lever lasers via modification of the cavity geometry. Our designs allow gain-lever lasers to achieve high slope efficiency, low nonlinearity, large modulation bandwidth, and large output power all at the same time. The ideas presented in this paper could allow cost-effective highmodulation-efficiency laser sources for analog fiber-optic and fiber/coax hybrid communication links.

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